

Study of  $HH \rightarrow WW^* WW^* \rightarrow 2Lss$  channel analysis

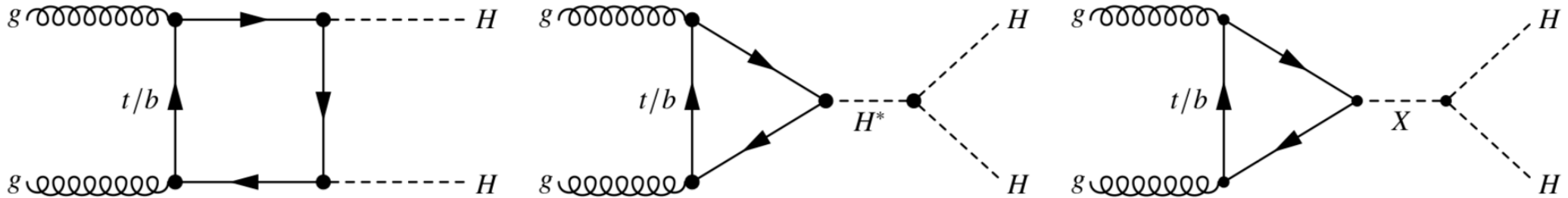
status report

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# Overview

- A review of 2LSS analysis
- Work on the ttHMultiGFW2 framework

# di-Higgs production in SM and BSM



- SM gluon-gluon fusion via a heavy-quark loop and Higgs self-coupling

$$pp \rightarrow HH \rightarrow WW^{(*)}WW^{(*)}$$

- BSM though an intermediate resonance

$$pp \rightarrow X \rightarrow WW^{(*)}WW^{(*)}$$

- Final state

$$WW^{(*)}WW^{(*)} \rightarrow \ell\nu + \ell\nu + 4q \quad \text{Required same-signed leptons to suppress ttbar, Drell-Yan, W+W- processes}$$

# Object definition

Loose selection: all leptons are required, used for defining CR and estimating background

Tight selection: define SR.

- Leptons

electron	ET > 10 GeV, $ \eta  < 2.47$ , removed $1.37 <  \eta  < 1.52$	
	Loose selection	Tight selection
	LooseLH ID Loose isolation $ z_0 \sin \theta  < 0.5 \text{mm}, d_0 / \sigma(d_0) < 5$	TightLH ID, FixedCutTight $E_T^{\text{cone20}} / p_T < 0.06, p_T^{\text{varcone20}} / p_T < 0.06$
muon	$p_T > 10 \text{ GeV},  \eta  < 2.5$	
	Loose selection	Tight selection
	Loose ID, Loose isolation $ z_0 \sin \theta  < 0.5 \text{mm}, d_0 / \sigma(d_0) < 3$	Tight ID, FixedCutTightTrackOnly $p_T^{\text{varcone20}} / p_T < 0.06$

- jets

$$p_T > 25 \text{ GeV}, |\eta| < 2.5 \quad |JVT| < 0.59 \text{ if } p_T < 60 \text{ GeV and } |\eta| < 2.4$$

- Missing transverse energy

$$p_T^{\text{track}} > 500 \text{ MeV}$$

$$|z_0 \sin \theta| < 3 \text{ mm}, d_0 / \sigma(d_0) < 2$$

- Overlap removal

Keep	Remove	Cone size ( $\Delta R$ )
muon	electron	0.1
electron	electron (lower $p_T$ )	0.1
electron	jet	0.3
jet	muon	$\min(0.4, 0.04 + 10[\text{GeV}] / p_T(\mu))$

# Event selection

- Pre-selections

Pre-selections	<p>GRL</p> <p>Event clean criteria</p> <p>Pass any trigger applied</p> <p>Select objects following object definitions</p> <p>Overlap removal</p> <p>Two tight same-signed leptons, with at least one trigger matched</p> <p><math>p_T(\ell_1) &gt; 30 \text{ GeV}, p_T(\ell_2) &gt; 20 \text{ GeV}</math></p> <p><math>b</math> veto</p> <p><math>E_T^{miss} &gt; 10 \text{ GeV}</math></p> <p><math>M(\ell\ell) &gt; 15 \text{ GeV}</math></p> <p><math> M(\ell\ell) - M(Z)  &gt; 10 \text{ GeV}</math> in <math>ee</math> channel</p> <p><math>N_{\text{jet}} \geq 2(3)</math></p>
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- Signal optimization
  - For high mass work point , 400 GeV, 500 GeV,  $N_{\text{jet}} \geq 3$
  - For low mass work point , 260 GeV and 300 GeV ,  $N_{\text{jet}} \geq 2$
  - Some kinematic variables are used to form optimization cuts.

# Background estimation

- Background source

- PromptSS:  $ttV$ ,  $VV$  ( $W^\pm W^\pm$ ,  $WZ$ ,  $ZZ$ ),  $tV$  and  $t\bar{t}H$  ( $H \rightarrow W^\pm W^\mp$ ,  $\tau\tau$ , and  $ZZ$ )

Estimated by MC

- QmisID:  $Z$ +jets and  $t\bar{t}$

Likelihood function technique -> ATL-COM-PHYS-2012-164 (2012).

- fakes :  $W$ +jets and  $t\bar{t}$

Fake factor method -> [http://dx.doi.org/10.1007/978-3-319-10344-0\\_9](http://dx.doi.org/10.1007/978-3-319-10344-0_9)

# Fake factor estimation

- Fake factor:  $\theta_\ell = \frac{N_{\ell\ell}}{N_{\ell f}}$
- Definition of tight and anti-tight lepton

- Electron

	tight electron	anti-tight electron
ID	TightLH	fail TightLH
isolation	isolationFixedCutTight	-
QmisID	ChargeIDBDTTight>0.067	ChargeIDBDTTight>0.067

- muon

	tight muon	anti-tight muon
ID	Tight	-
isolation	isolationFixedCutTightTrackOnly	fail isolationFixedCutTightTrackOnly

- The result is agree with previous paper

# Fake factor estimation

- Summary of fake factor

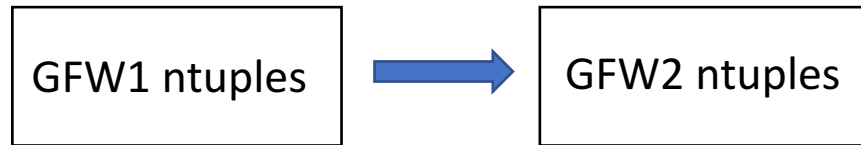
N_jet=1	theta_e	0.5401
	theta_u	0.5033
1<N_jet<2	theta_e	0.5472
	theta_u	0.4544

- Jet fakes in three channels

selection	N_jet>=2			N_jet>=3		
	ee	eu	uu	ee	eu	uu
Event yield	318.27±9.64	256.20±8.06	332.69±9.62	127.38±6.10	122.97±5.58	138.25±6.16



# ttHMultiGFW2 framework



- Apply event selection, slim GFW1 ntuples to GFW2 ntuples to meet our needs
- Try to test GFW2 package locally (succeed).
- Problem occurred when ran on the grid.

# What to do

- Optimize signal region

TMVA package is used. How about new method?

- Systematic study

Analysis the uncertainty of fakes, and other Systematic uncertainties

- Update new datas and samples

- Develop ttHMultiGFW2 framework

To dump N2 that we require.